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FDMS86150ET100

## N-Channel Shielded Gate PowerTrench<sup>®</sup> MOSFET 100 V, 128 A, 4.85 m $\Omega$

#### Features

- Extended T<sub>J</sub> rating to 175°C
- Shielded Gate MOSFET Technology
- Max  $r_{DS(on)}$  = 4.85 m $\Omega$  at V<sub>GS</sub> = 10 V, I<sub>D</sub> = 16 A
- Max  $r_{DS(on)}$  = 7.8 m $\Omega$  at V<sub>GS</sub> = 6 V, I<sub>D</sub> = 13 A
- Advanced Package and Silicon combination for low r<sub>DS(on)</sub> and high efficiency
- MSL1 robust package design
- 100% UIL tested
- RoHS Compliant

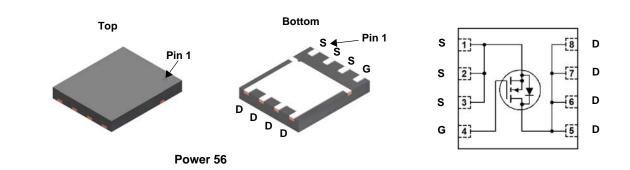


### **General Description**

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench<sup>®</sup> process that incorporates Shielded Gate technology. This process has been optimized for the on-state resistance and yet maintain superior switching performance.

### Applications

- Primary DC-DC MOSFET
- Secondary Synchronous Rectifier
- Load Switch



#### MOSFET Maximum Ratings T<sub>A</sub> = 25 °C unless otherwise noted

Symbol	Parameter			Ratings	Units	
V <sub>DS</sub>	Drain to Source Voltage			100	V	
V <sub>GS</sub>	Gate to Source Voltage			±20	V	
	Drain Current -Continuous	T <sub>C</sub> = 25 °C	(Note 5)	128		
	-Continuous	T <sub>C</sub> = 100 °C	(Note 5)	90		
ID.	-Continuous	T <sub>A</sub> = 25 °C	(Note 1a)	16	Α	
	-Pulsed		(Note 4)	617		
E <sub>AS</sub>	Single Pulse Avalanche Energy		(Note 3)	726	mJ	
P <sub>D</sub>	Power Dissipation	T <sub>C</sub> = 25 °C		187		
	Power Dissipation	T <sub>A</sub> = 25 °C	(Note 1a)	3.3		
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Tempera	ature Range		-55 to +175	°C	

#### **Thermal Characteristics**

$R_{\theta JC}$	Thermal Resistance, Junction to Case	0.8	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1	a) 45	C/VV

#### Package Marking and Ordering Information

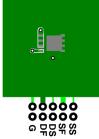
Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS86150ET	FDMS86150ET100	Power 56	13 "	12 mm	3000 units

FDMS86150ET100 N-Channel Shielded Gate PowerTrench <sup>®</sup> MOS
iate PowerTrench <sup>®</sup> N
 NOSFET

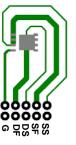
Symbol	Parameter	Test Conditions	Min	Тур	Max	Units	
Off Chara	acteristics						
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	I <sub>D</sub> = 250 μA, V <sub>GS</sub> = 0 V	100			V	
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$ , referenced to 25 °C		72		mV/°C	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 80 V, V_{GS} = 0 V$			1	μA	
I <sub>GSS</sub>	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±100	nA	
On Chara	acteristics						
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \ \mu A$	2	3	4	V	
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$ , referenced to 25 °C		-10		mV/°C	
	Static Drain to Source On Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 16 A		3.9	4.85	mΩ	
r <sub>DS(on)</sub>		V <sub>GS</sub> = 6 V, I <sub>D</sub> = 13 A		6	7.8		
		$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 16 \text{ A}, \text{ T}_{J} = 125 \text{ °C}$		7.3	9.1		
9 <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 16 A		53		S	
C <sub>iss</sub> C <sub>oss</sub>	Input Capacitance Output Capacitance	V <sub>DS</sub> = 50 V, V <sub>GS</sub> = 0 V, f = 1 MHz		3055 696	4065 930	pF pF	
C <sub>oss</sub>	Output Capacitance			696	930	pF	
C <sub>rss</sub>	Reverse Transfer Capacitance			29	50	pF	
R <sub>g</sub>	Gate Resistance		0.1	0.7	3.6	Ω	
Switching	g Characteristics						
t <sub>d(on)</sub>	Turn-On Delay Time			18	33	ns	
t <sub>r</sub>	Rise Time			8.3	17	~~	
	Rise Time	$V_{DD} = 50 \text{ V}, I_D = 16 \text{ A},$				ns	
	Turn-Off Delay Time	$V_{DD}$ = 50 V, I <sub>D</sub> = 16 A, V <sub>GS</sub> = 10 V, R <sub>GEN</sub> = 6 Ω		28	45	ns	
t <sub>d(off)</sub>				28 6			
t <sub>d(off)</sub> t <sub>f</sub>	Turn-Off Delay Time			-	45	ns	
t <sub>d(off)</sub> t <sub>f</sub> Q <sub>g</sub>	Turn-Off Delay Time Fall Time	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ V to } 10 \text{ V}$		6	45 12	ns ns	
t <sub>d(off)</sub> t <sub>f</sub> Q <sub>g</sub> Q <sub>g</sub>	Turn-Off Delay Time         Fall Time         Total Gate Charge	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ V to } 10 \text{ V}$		6 44	45 12 62	ns ns nC	
t <sub>d(off)</sub> t <sub>f</sub> Q <sub>g</sub> Q <sub>g</sub> Q <sub>gs</sub>	Turn-Off Delay Time         Fall Time         Total Gate Charge         Total Gate Charge	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ V to } 10 \text{ V}$ $V_{GS} = 0 \text{ V to } 5 \text{ V}$ $V_{DD} = 50 \text{ V},$		6 44 25	45 12 62	ns ns nC nC	
<sup>t</sup> d(off) t <sub>f</sub> Qg Qg Qgs Qgd	Turn-Off Delay Time         Fall Time         Total Gate Charge         Total Gate Charge         Gate to Source Charge	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ V to } 10 \text{ V}$ $V_{GS} = 0 \text{ V to } 5 \text{ V}$ $V_{DD} = 50 \text{ V},$		6 44 25 12.9	45 12 62	ns ns nC nC nC	
$t_{d(off)}$ $t_{f}$ $Q_{g}$ $Q_{g}$ $Q_{gs}$ $Q_{gd}$ Drain-So	Turn-Off Delay Time         Fall Time         Total Gate Charge         Total Gate Charge         Gate to Source Charge         Gate to Drain "Miller" Charge         urce Diode Characteristics	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ V to } 10 \text{ V}$ $V_{GS} = 0 \text{ V to } 5 \text{ V}$ $I_D = 50 \text{ V},$ $I_D = 16 \text{ A}$ $V_{GS} = 0 \text{ V}, \text{ I}_S = 2.1 \text{ A}$ (Note 2)		6 44 25 12.9	45 12 62	ns nS nC nC nC nC	
$t_{d(off)}$ $t_{f}$ $Q_{g}$ $Q_{g}$ $Q_{gs}$ $Q_{gd}$ Drain-So	Turn-Off Delay TimeFall TimeTotal Gate ChargeTotal Gate ChargeGate to Source ChargeGate to Drain "Miller" Charge	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ V to } 10 \text{ V}$ $V_{GS} = 0 \text{ V to } 5 \text{ V}$ $V_{DD} = 50 \text{ V},$ $I_{D} = 16 \text{ A}$		6 44 25 12.9 9.2	45 12 62 35	ns ns nC nC nC	
t <sub>d(off)</sub> t <sub>f</sub> Q <sub>g</sub> Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub>	Turn-Off Delay Time         Fall Time         Total Gate Charge         Total Gate Charge         Gate to Source Charge         Gate to Drain "Miller" Charge         urce Diode Characteristics	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ V to } 10 \text{ V}$ $V_{GS} = 0 \text{ V to } 5 \text{ V}$ $I_D = 50 \text{ V},$ $I_D = 16 \text{ A}$ $V_{GS} = 0 \text{ V}, \text{ I}_S = 2.1 \text{ A}$ (Note 2)		6 44 25 12.9 9.2 0.69	45 12 62 35 1.2	ns nS nC nC nC	

Notes:

1.  $R_{\theta JA}$  is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material.  $R_{\theta CA}$  is determined by the user's board design.



a. 45 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper.



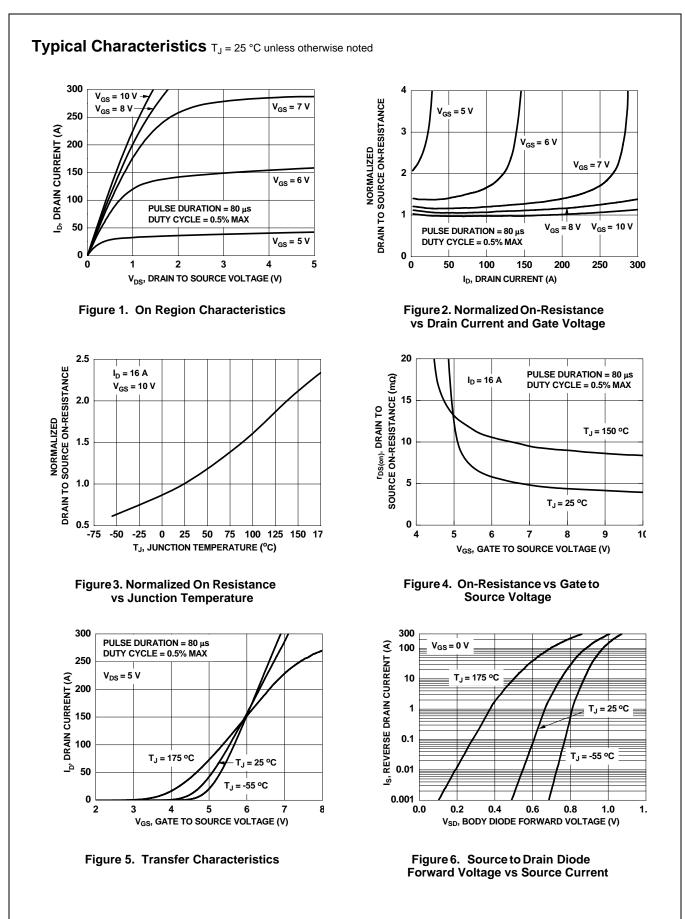
b. 115 °C/W when mounted on a minimum pad of 2 oz copper.

3.  $E_{AS}$  of 726 mJ is based on starting  $T_J$  = 25 °C, L = 3 mH,  $I_{AS}$  = 22 A,  $V_{DD}$  = 100 V,  $V_{GS}$  = 10 V, 100% test at L = 0.1 mH,  $I_{AS}$  = 69 A.

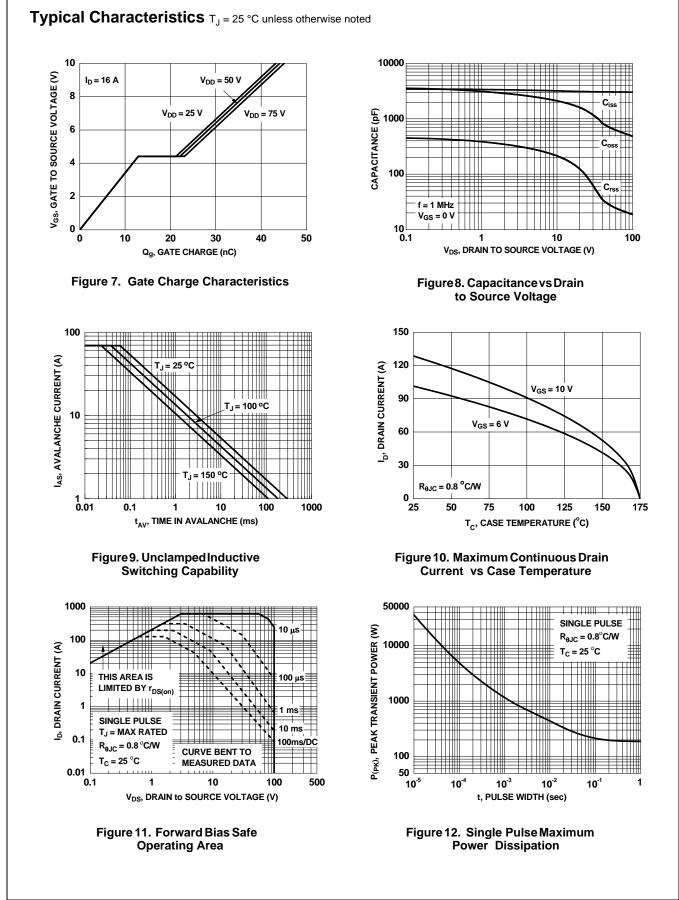
4. Pulse Id please refer to Fig.11 SOA curve for detail.

5. Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

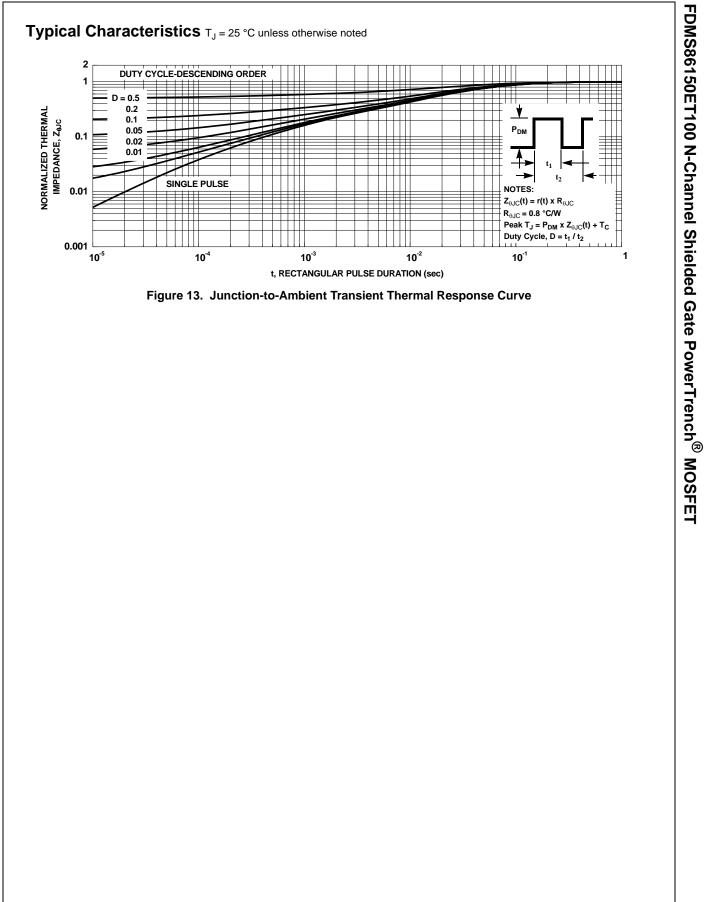
FDMS86150ET100 N-Channel Shielded Gate PowerTrench<sup>®</sup> MOSFET

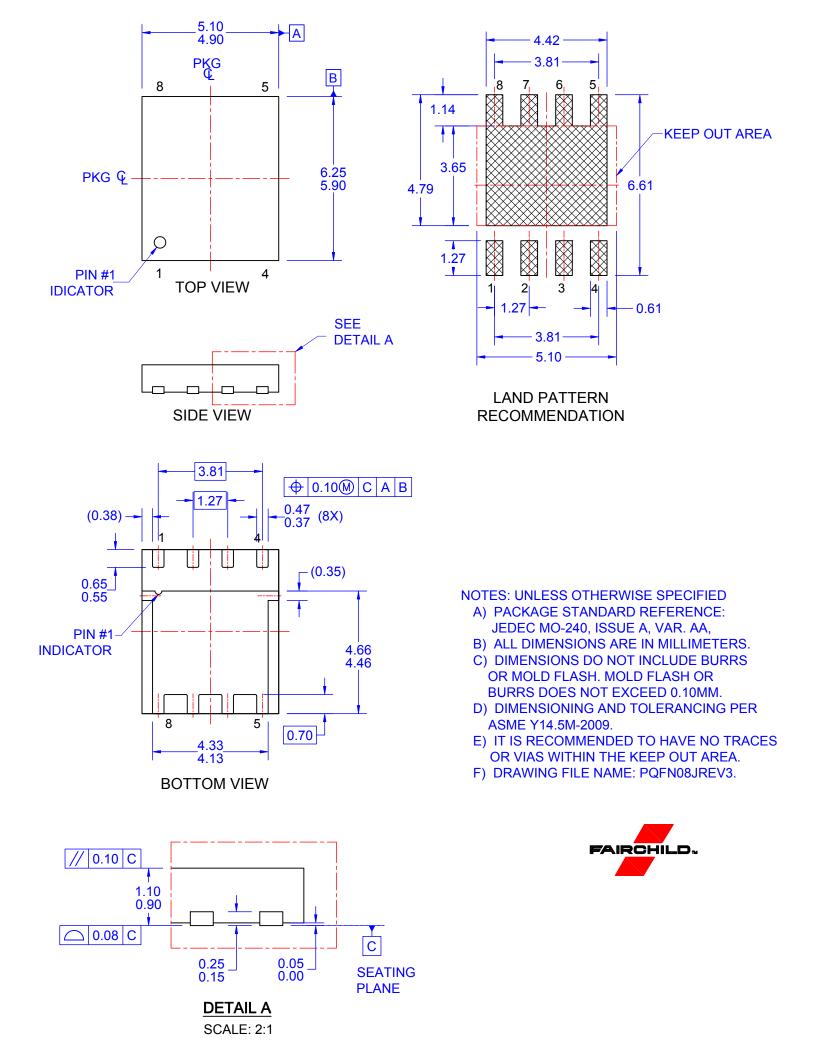


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FDMS86150ET100 N-Channel Shielded Gate PowerTrench<sup>®</sup> MOSFET





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